

CANADIAN LIGHT SOURCE Inc. REIXS General User Mail-In Form



Project number: 32S10257

Principal Investigator/Spokesperson: Teak Boyko

Endstation: RSXS RIXS

Sample Information

#	Sample Name / ID	Type	Chemical Composition	Lattice Parameter	Additional Information
1	Lithium Iridium Oxide 3	Thin Film	Li ₃ IrO ₄	N/A	Needs to be mounted on carbon tape in an inert atmosphere; glove bag or equivalent. Argon atmosphere is best, but nitrogen is adequate.
2	Lithium Iridium Oxide 2	Thin Film	Li ₂ IrO ₄	N/A	Needs to be mounted on carbon tape in an inert atmosphere; glove bag or equivalent. Argon atmosphere is best, but nitrogen is adequate.
3	Lithium Iridium Oxide 1	Thin Film	LiIrO ₄	N/A	Needs to be mounted on carbon tape in an inert atmosphere; glove bag or equivalent. Argon atmosphere is best, but nitrogen is adequate.
4	Iridium Oxide	Powder	IrO ₄	N/A	Mount on copper tape.
5	Magnesium Oxide	Powder	MgO	N/A	Mount on copper tape.

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Experimental procedures

- Please copy the table below in accordance to the number of samples listed in the "Sample Information" table above.
- If needed, please add the number of lines in the table by clicking the plus button on the right.
- For "[Scan Type]: Scan Range" column, the sequence for the Scan Range is initial value, final value, and step with a default of 1 sec counting time. [Scan type] is optional and can be used to specify other standard scans, for example, lscan, tscan, etc. for the RSXS endstation or Tscan for the RIXS endstation.
- If a custom region or mesh scan needed, please specify in the "Additional Information" column.

Sample Numbers: 1-4							
Scan #	Experimental Technique	[Scan Type]: Scan Range (initial, final, step, [time])	Polarization	T (K)	Energy (eV)	Detectors	Additional Information
1	XAS	Escan 520 560 variable 3	lh	299	N/A	SDD	Use only the SDD; take 0.2 eV steps on the pre-edge, 0.05 eV steps across the main edge (10 eV wide), 0.1 eV steps for an additional 10 eV and 0.2 eV steps for the remaining region.
2	XES	Tscan 30 1200	lh	299	560	XES	Non-resonant XES, use MEG for spectrometer.
3	XES	Tscan 30 600	lh	299	Variable	XES	Excite on all prominent peaks, use MEG for spectrometer
4	EEM	Escan 525 535 100 30	lh	299	N/A	XES, SDD, XEOL	EEMs spectrum, use MEG for spectrometer, repeat 6X
5	XEOL	Tscan 30 1200	lh	299	560	XEOL	Non-resonant XEOL spectrum.

Sample Numbers: 5							
Scan #	Experimental Technique	[Scan Type]: Scan Range (initial, final, step, [time])	Polarization	T (K)	Energy (eV)	Detectors	Additional Information
1	XAS	Escan 520 560 variable 3	lh	299	N/A	SDD	Same as scan 1 for samples 1-4.
1	XAS	Tscan 30 600	lh	299	560	XES	Same as scan 2 for samples 1-4.

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Date of Sample Delivery: 12/17/2020

Principle Investigator Signature:

Teak D. Boyko

Date: 12/17/2020

Beamline Scientist Signature:

Teak D. Boyko

Date: 12/17/2020